JC13 RE PCT/PTO 31 MAR 2005

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of	)	Examiner: Unknown
Johan Samuel VAN DEN BRINK	)	Art Unit: Unknown
	)	
Serial No.: not assigned	)	
	)	
Filed: herewith	)	
	)	
Title: A Method for K-Space Data	)	
Acquisition and MRI Device	j	
•	Ś	Cleveland, Ohio 44143
Attorney Docket No.: PHNL020945US	Ś	March 31, 2005
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Information Disclosure Statement under 37 CFR 1.97(b)(3)

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Further to the filing of the National Stage Entry of PCT patent application, serial number PCT/IB2003/004014, Applicant submits an Information Disclosure Statement under 37 CFR 1.97(b)(3). Along with the foreign and article references, Applicant also encloses a form PTO/ISB/08A listing all of the references for the Examiner's convenience.

Applicant believes that no charge is due for the submission of this Information Disclosure Statement. However, please charge any necessary fees in connection with this submission to our Deposit Account No. 14-1270.

Respectfully submitted,

Thomas M. Lundin Reg. No. 48,979

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Substitute for form 1449/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Complete if Known Application Number unknown Filing Date herewith First Named Inventor Johan VanDenBrink Art Unit unknown Examiner Name unknown Attorney Docket Number PHNL020945US

			U. S. PATENT	DOCUMENTS	
Examiner Initials*	Cite No. <sup>1</sup>	Document Number  Number-Kind Code <sup>2 (# known)</sup>	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	<b>†</b>	<sup>US-</sup> 6,044,290	03-28-2000	Vigen, et al.	all
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	FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document  Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> ( <i>if known</i> )	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T <sup>6</sup>
		WO 02/35250 A1	05-02-2002	Song	all	
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Examiner		Date	
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Translation is attached.

This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, Washington, DC 20231.

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INFO	ORMATION	DIS	CLOSURE	Filing Date	herewith
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Sheet	2	of	2	Attorney Docket Number	PHNL020945US

Eversine:	C:4-	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
		BUONOCORE, M., et al.; High Spatial Resolution EPI Using an Odd Number of Interleaves; MRM; 1999; 41:1199-1205.	
		CONSTABLE, R.T., et al.; Composite Image Formation in z-Shimmed Functional MR Imaging; MRM; 1999; 42:110-117.	
		GLOVER, G.H.; 3D z-Shim Method for Reduction of Susceptibility Effects in BOLD fMRI; MRM; 1999; 42:290-299.	
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		MANSFIELD, P.; Multi-planar image formation using NMR spin echoes; J. Phys. C: 1977; Vol. 10, pp. L55-L58.	
		PANYCH, L.P., et al.; Selection of High-Definition 2D Virtual Profiles; MRM; 1999; 41:224-229.	
_		SONG, A.W.; Single-Shot EPI with Signal Recovery from the Susceptibility-Induced Losses; MRM; 2001; 46:407-411.	

Examiner	Date
Signature	Considered

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